

# N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}$ ( $\Omega$ ) Max.	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
100	0.010 at V <sub>GS</sub> = 10 V	12	0.7.50			
100	0.012 at V <sub>GS</sub> = 4.5 V	9.5	9.7 nC			

# SO-8 S 1 S 2 T D G 4 SO-8

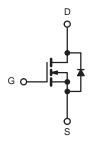
#### **FEATURES**

- DT-Trench Power MOSFET
- 100 %  $R_g$  and UIS Tested
- Material categorization:

# RoHS COMPLIANT

#### **APPLICATIONS**

- DC/DC Primary Side Switch
- Telecom/Server
- Industrial
- Synchronous Rectification



N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATIN</b>	IGS (T <sub>A</sub> = 25 °C	, unless other	wise noted)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	100	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	V
	T <sub>C</sub> = 25 °C		12	
Continuous Proin Current (T. 450 °C)	T <sub>C</sub> = 70 °C	1 ,	8.8	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	7.3 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		5.8 <sup>b, c</sup>	
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	48	Α
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		5.1	
	T <sub>A</sub> = 25 °C	- I <sub>S</sub> -	2.2 <sup>b, c</sup>	
Single Pulse Avalanche Current	1 0411	I <sub>AS</sub>	15	
Avalanche Energy L = 0.1 mH		E <sub>AS</sub>	100	mJ
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		5.7	
	T <sub>C</sub> = 70 °C		3.6	10/
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.5 <sup>b, c</sup>	W
	T <sub>A</sub> = 70 °C		1.6 <sup>b, c</sup>	
Operating Junction and Storage Temperature	e Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	35	50	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	18	22	C/ V V	

#### Notes:

- a. Based on  $T_C = 25$  °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 85 °C/W.





Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	-				'		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 250		67		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I <sub>D</sub> = 250 μA		- 5			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu\text{A}$	1.0		3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oata Wallana Busin Oamani	1	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V			1	μА	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
		$V_{GS} = 10 \text{ V}, I_{D} = 7 \text{ A}$		0.010	0.012	112 113 Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 7.5 \text{ V}, I_D = 5 \text{ A}$		0.011	0.013		
	. ,	$V_{GS} = 4.5 \text{ V}, I_{D} = 4 \text{ A}$		0.012	0.014		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 10 A		26		S	
Dynamic <sup>b</sup>					l		
Input Capacitance	C <sub>iss</sub>			2604			
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		361.2		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			65			
·		$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$	19.6	29.5	<del>                                     </del>		
Total Gate Charge	$Q_g$	30 30 2		9.7	15	nC	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 50 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		2.8			
Gate-Drain Charge	Q <sub>gd</sub>			4.3			
Output Charge	Q <sub>oss</sub>	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V		26.2	40		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	0.2	0.85	1.7	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			13	26		
Rise Time	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, R_L = 5 \Omega$		14	28		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 7.5 \text{ V}, R_g = 1 \Omega$		19	38		
Fall Time				10	20		
Turn-On Delay Time	t <sub>d(on)</sub>			11	22	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, R_L = 5 \Omega$		10	20		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		20	40		
Fall Time	t <sub>f</sub>			9	18		
<b>Drain-Source Body Diode Characteristi</b>	cs				·		
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			5.1	Ι.	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				48	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 4 A		0.77	1.1	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			34	65	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1 5 A 31/41 400 A/ T 57 30		34	65	nC	
Reverse Recovery Fall Time t <sub>a</sub>		$I_F = 5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		20		1	
Reverse Recovery Rise Time		$\dashv$		14		ns	

#### Notes

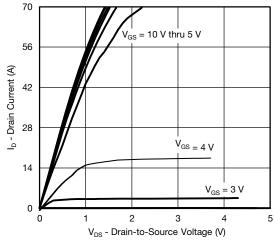
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%$ 

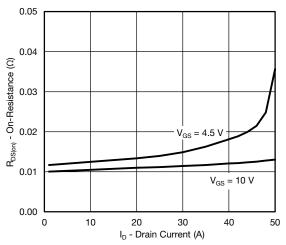
b. Guaranteed by design, not subject to production testing.



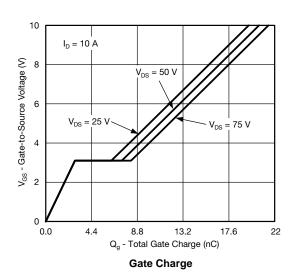
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

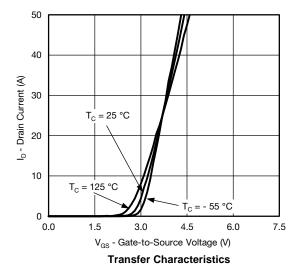


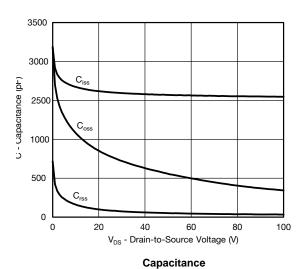
#### **Output Characteristics**

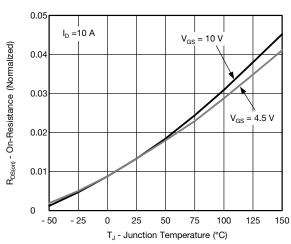


On-Resistance vs. Drain Current





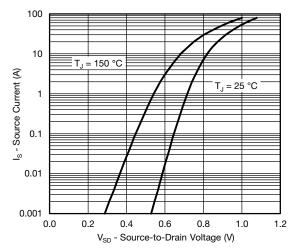




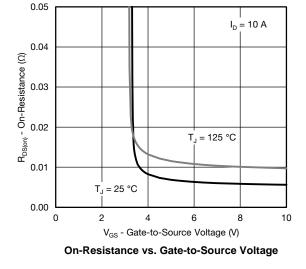
On-Resistance vs. Junction Temperature

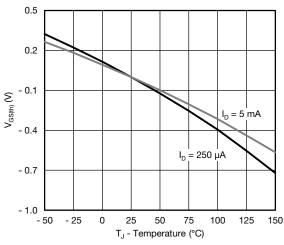


#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

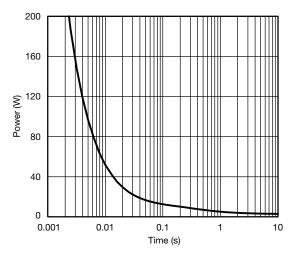


#### Source-Drain Diode Forward Voltage

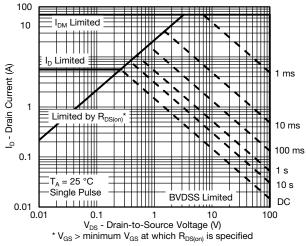




Threshold Voltage

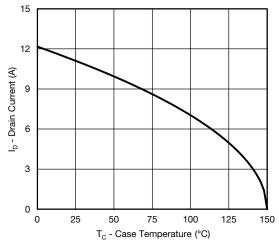


Single Pulse Power, Junction-to-Ambient

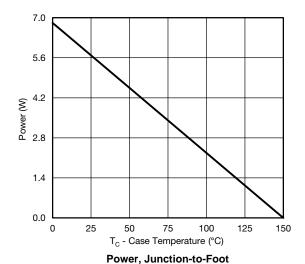


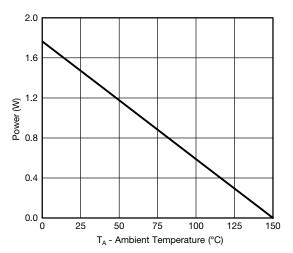
Safe Operating Area, Junction-to-Ambient

#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### **Current Derating\***



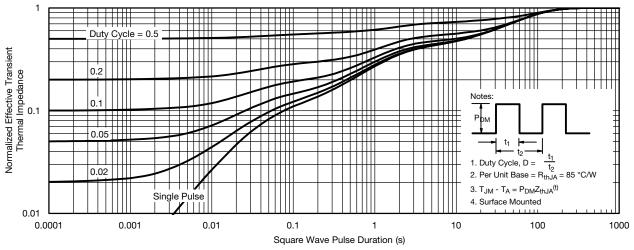


Power, Junction-to-Ambient

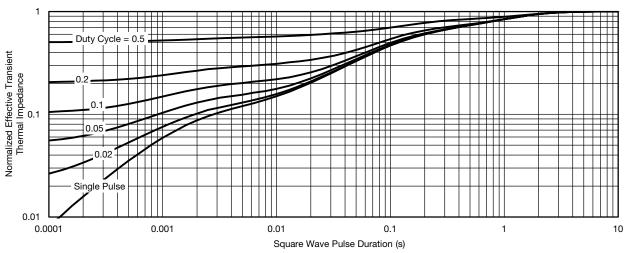
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



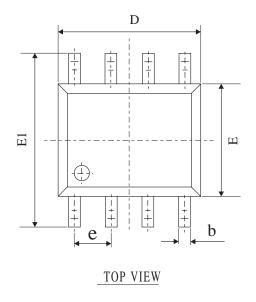
Normalized Thermal Transient Impedance, Junction-to-Ambient

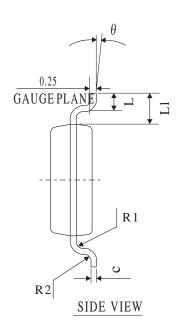


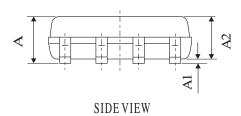
Normalized Thermal Transient Impedance, Junction-to-Foot



# **SOP-8 PACKAGE OUTLINE**







COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX		
A	1.30	1.60	1.85		
A1	0.03	0.15	0.28		
A2	1.20	1.45	1.70		
b	0.26	0.40	0.54		
С	0.132	0.203	0.273		
D	4.50	4.90	5.30		
Е	3.50	3.00	4.30		
E1	5.50	6.00	6.50		
L	0.30	0 0.70 1.10			
θ	2° 4° 6°				
L1	1.04REF				
e	1.27BSC				
R1	0.07TYP				
R2	0.07TYP				





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